

Notice of References Cited	Application/Control No. 10/579,086		Applicant(s)/Patent Under Reexamination KROON, ARIE	
	Examiner JASON HECKERT		Art Unit 1711	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0159447	08-2003	Sergio et al.	62/3.64
*	B	US-2004/0118291	06-2004	Carhuff et al.	099/275
	C	US-			
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	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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*	N	WO 03/050045	12-2001	Netherlands	Biesheuvel et al.	
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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